

# Search Notes



Application/Control No.

10/632,006

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

3753

## SEARCHED

Class	Subclass	Date	Examiner
137	315.42	7/28/2005	KL
UPDATED	SEARCH	7/28/2005	KL

## INTERFERENCE SEARCHED

Class <sup>2</sup>	Subclass	Date	Examiner
see interference		7/28/05	KL
search history			
printout			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
INTERFERENCE search- see search history printout	7/28/2005	KL